

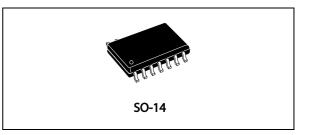
Advanced IGBT/MOSFET driver

Features

- 1.5 A source/2.3 A sink (typ) gate drive
- Active Miller clamp feature
- Two-level turn-off with adjustable level and delay
- Desaturation detection
- Fault status output
- Negative gate drive capability
- Input compatible with pulse transformer or optocoupler
- Separate sink and source outputs for easy gate driving
- UVLO protection
- 2 kV ESD protection (HBM)

Applications

- 1200 V, 3-phase inverters
- Motor control
- UPS systems



Description

This device is an advanced gate driver for IGBTs and power MOSFETs. Control and protection functions are included and allow the design of high reliability systems.

The innovative active Miller clamp function eliminates the need for negative gate drive in most applications and allows the use of a simple bootstrap supply for the high side driver.

The device includes a two-level turn-off feature with adjustable level and delay. This function protects against excessive overvoltage at turn-off in case of overcurrent or short-circuit conditions. The same delay set in the two-level turn-off feature is applied at turn-on to prevent pulse width distortion.

The device also includes IGBT desaturation protection and a FAULT status output, and is compatible with both pulse transformer and optocoupler signals.

Table 1. Device summary

Order codes	Temperature range	Package	Packaging	
TD350E	-40, +125 °C	SO-14	Tube	
TD350ETR			Tape and reel	

Contents TD350E

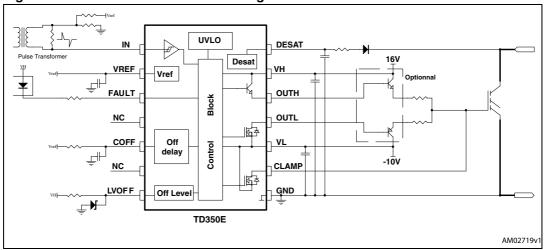
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TD350E Block diagram

1 Block diagram

Figure 1. TD350E functional block diagram



Pin connections TD350E

2 Pin connections

Figure 2. Pin connections (top view)

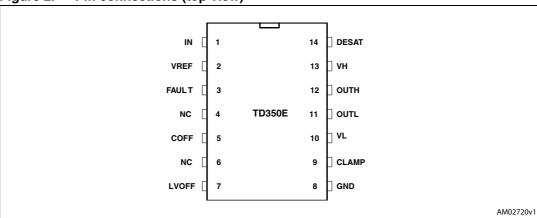


Table 2. Pin description

Name	Pin number	Туре	Function
IN	1	Analog input	Input
VREF	2	Analog output	+5 V reference voltage
FAULT	3	Digital output	Fault status output
NC	4	Not connected	
COFF	5	Timing capacitor	Turn-off delay
NC	6	Not connected	
LVOFF	7	Analog input Turn off level	
GND	8	Power supply	Signal ground
CLAMP	9	Analog output	Miller clamp
VL	10	Power supply	Negative supply
OUTL	11	Analog output	Gate drive output (sink)
OUTH	12	Analog output Gate drive output (source)	
VH	13	Power supply Positive supply	
DESAT	14	Analog input Desaturation protection	

3 Absolute maximum ratings

Table 3. Key parameters and their absolute maximum ratings

Symbol	Parameter	Value	Unit
VHL	Maximum supply voltage (VH - VL)	28	V
VH	Maximum VH voltage vs. GND	28	٧
VL	Minimum VL voltage vs. GND	-12	٧
V _{out}	Voltage on OUTH, OUTL, CLAMP pins	VL-0.3 to VH+0.3	٧
V _{des}	Voltage on DESAT, FAULT, LVOFF pin	-0.3 to VH+0.3	٧
V _{other}	Voltage on other pins (IN, COFF, VREF)	-0.3 to 7	٧
P _d	Power dissipation	500	mW
T _{stg}	Storage temperature	-55 to 150	°C
T _j	Maximum junction temperature	150	°C
R _{thja}	Thermal resistance junction-ambient	125	°C/W
R _{thjc}	Thermal resistance junction-case	22	°C/W
ESD	Electrostatic discharge (HBM)	2	kV

Table 4. Operating conditions

Symbol	Parameter	Value	Unit
VH	Positive supply voltage vs. GND	UVLO to 26	V
VL	Negative supply voltage vs. GND	0 to -10	V
VH-VL	Maximum total supply voltage	26	٧
T _{oper}	Operating free air temperature range	-40 to 125	°C

Electrical characteristics TD350E

4 Electrical characteristics

 T_A = -20 to 125 °C, VH=16 V, VL= -10 V (unless otherwise specified)

Table 5. Electrical characteristics

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
Input				•	•	
V _{ton}	IN turn-on threshold voltage		0.8	1.0		V
V _{toff}	IN turn-off threshold voltage			4.0	4.2	٧
t _{onmin}	Minimum pulse width		100	135	220	ns
I _{inp}	IN input current				1	μА
Voltage re	eference ⁽¹⁾					
V _{ref}	Voltage reference	T=25°C T _{min} <t<t<sub>max</t<t<sub>	4.85 4.77	5.00	5.15 5.22	V V
I _{ref}	Maximum output current		10			mA
Desatura	tion protection					
V _{des}	Desaturation threshold		6.5	7.2	7.9	V
I _{des}	Source current			250		μА
Fault out	put					
t _{fault}	Delay for fault detection				500	ns
V_{FL}	FAULT low voltage	I _{FLsink} =10mA			1	V
Clamp						
V _{tclamp}	CLAMP pin voltage threshold			2.0		٧
V _{CL}	Clamp low voltage	T=25°C; I _{CLsink} =500mA T _{min} <t<t<sub>max; I_{CLsink}=500mA</t<t<sub>			VL+2.5 VL+3.0	V V
Off delay						
V _{tdel}	Voltage threshold		2.35	2.50	2.65	V
R _{del}	Discharge resistor	I=1mA			500	Ω
Off levels						
I _{blvoff}	LVOFF peak input current (sink)	LVOFF=12V		120	200	μА
V _{iolv}	Offset voltage	LVOFF=12V	-0.3	-0.15	0	V
Outputs						
V _{OL1}	Output low voltage at I _{osink} =20mA				VL+0.35	V
V _{OL2}	Output low voltage at I _{osink} =200mA	T=25°C T _{min} <t<t<sub>max</t<t<sub>			VL+1.0 VL+1.5	V V

Table 5. Electrical characteristics (continued)

Parameter	Test condition	Min	Тур	Max	Unit	
Output low voltage at I _{osink} =500mA	T=25°C T _{min} <t<t<sub>max</t<t<sub>			VL+2.5 VL+3.0	V V	
Output high voltage 1	I _{osource} =20 mA	VH-2.5			V	
Output high voltage 2	I _{osource} =200 mA	VH-3.0			V	
Output high voltage 3	I _{osource} =500 mA	VH-4.0			V	
Rise time	C _L =1nF, 10% to 90% VL=0 VL=-10V			130 175	ns ns	
Fall time ⁽²⁾	C _L =1nF, 90% to 10% VL=0 VL=-10V			75 90	ns ns	
Turn-on propagation delay	10% output change; T=25°C	400	500	600	ns	
	10% output change; T _{min} <t<t<sub>max</t<t<sub>	350		650	ns	
- "	10% output change; T=25°C	350	450	570	ns	
Turn-on propagation delay	10% output change; T _{min} <t<t<sub>max</t<t<sub>	300		620	ns	
Input to output pulse distortion	10% output change	25	50	120	ns	
tage lockout (UVLO)				•	•	
UVLO top threshold		10	11	12	V	
UVLO bottom threshold		9	10	11	V	
UVLO hysteresis	UVLOH-UVLOL	0.5	1		V	
V _{hyst} UVLO hysteresis UVLOH-UVLOL 0.5 1 V Supply current						
Quiescent current	Output=0 V, no load			5	mA	
	Output low voltage at Iosink=500mA Output high voltage 1 Output high voltage 2 Output high voltage 3 Rise time Fall time (2) Turn-on propagation delay Input to output pulse distortion age lockout (UVLO) UVLO top threshold UVLO bottom threshold UVLO hysteresis	Output low voltage at I _{osink} =500mA T=25°C T _{min} <t<t<sub>max Output high voltage 1 Output high voltage 2 I_{osource}=200 mA Output high voltage 3 I_{osource}=500 mA C_L=1nF, 10% to 90% VL=0 VL=-10V Fall time (2) Turn-on propagation delay Turn-off propagation delay Turn-off</t<t<sub>	Output low voltage at I _{osink} =500mA T=25°C T _{min} <t<t<sub>max VH-2.5 Output high voltage 1 I_{osource}=20 mA VH-2.5 Output high voltage 2 I_{osource}=200 mA VH-3.0 Output high voltage 3 I_{osource}=500 mA VH-4.0 Rise time C_L=1nF, 10% to 90% VL=0 VL=10V VL=0 VL=10V Fall time (2) C_L=1nF, 90% to 10% VL=0 VL=10V 400 Turn-on propagation delay T=25°C 10% output change; T=25°C 10% output change 25 350 Input to output pulse distortion 10% output change 25 350 age lockout (UVLO) UVLO top threshold 10 UVLO bottom threshold 9 UVLO hysteresis UVLOH-UVLOL</t<t<sub>	Output low voltage at I _{osink} =500mA T=25°C T _{min} <t<t<sub>max VH-2.5 Output high voltage 1 I_{osource}=20 mA VH-3.0 Output high voltage 2 I_{osource}=200 mA VH-3.0 Output high voltage 3 I_{osource}=500 mA VH-4.0 Rise time C_L=1nF, 10% to 90% VL=0 VL=-10V VL=0 VL=-10V Fall time (2) 10% output change; T=25°C 400 500 Turn-on propagation delay 10% output change; T=25°C 350 450 Turn-off propagation delay 10% output change; T=25°C 350 450 Input to output pulse distortion 10% output change; 300 300 Input to output pulse distortion 10% output change 25 50 age lockout (UVLO) UVLO top threshold 10 11 UVLO bottom threshold 9 10 UVLO hysteresis UVLOH-UVLOL 0.5 1</t<t<sub>	Output low voltage at I _{osink} =500mA T=25°C T _{min} <t<t<sub>max VL+2.5 VL+3.0 Output high voltage 1 I_{osource}=20 mA VH-2.5 VH-2.5 Output high voltage 2 I_{osource}=200 mA VH-3.0 VH-3.0 Output high voltage 3 I_{osource}=500 mA VH-4.0 VH-4.0 Rise time C_L=1nF, 10% to 90% VL=0 VL=-10V T130 T75 Fall time (2) C_L=1nF, 90% to 10% VL=-10V 75 90 Turn-on propagation delay 10% output change; T=25°C 350 60 10% output change; T=25°C 350 450 570 10% output change; T=25°C 300 620 Input to output pulse distortion 10% output change; T=25°C 300 620 Input to output pulse distortion 10% output change 25 50 120 age lockout (UVLO) UVLO top threshold 10 11 12 UVLO bottom threshold 9 10 11 UVLO hysteresis UVLOH-UVLOL 0.5 1</t<t<sub>	

^{1.} Recommended capacitor range on VREF pin is 10 nF to 100 nF.

^{2. 2-}step turn-off disabled

5 Functional description

5.1 Input

The input is compatible with optocouplers or pulse transformers. The input is triggered by the signal edge and allows the use of a small-sized, low-cost pulse transformer. Input is active low (output is high when input is low) to ease the use of the optocoupler. When driven by a pulse transformer, the input pulse (positive and negative) width must be larger than the minimum pulse width t_{onmin} .

5.2 Voltage reference

A voltage reference is used to create accurate timing for the two-level turn-off with external resistor and capacitor.

5.3 Desaturation protection

Desaturation protection ensures the protection of the IGBT in the event of overcurrent. When the DESAT voltage goes higher than 7 V, the output is driven low (with 2-level turn-off, if applicable). The FAULT output is activated. The FAULT state is exited at the next falling edge of IN input.

A programmable blanking time is used to allow enough time for IGBT saturation. Blanking time is provided by an internal current source and external capacitor.

DESAT input can also be used with an external comparator for overcurrent or overtemperature detection.

5.4 Active Miller clamp

A Miller clamp allows the control of the Miller current during a high dV/dt situation and can eliminate the need for a negative supply voltage.

During turn-off, the gate voltage is monitored and the clamp output is activated when gate voltage goes below 2 V (relative to GND). The clamp voltage is VL+3 V max for a Miller current up to 500 mA. The clamp is disabled when the IN input is triggered again.

5.5 Two-level turn-off

The two-level turn-off is used to increase the reliability of the application.

During turn-off, gate voltage can be reduced to a programmable level in order to reduce the IGBT current (in the event of overcurrent). This action prevents both dangerous overvoltage across the IGBT and RBSOA problems, especially at short-circuit turn-off.

Turn-off (T_a) delay is programmable through an external resistor and capacitor for accurate timing.

Turn-off delay (T_a) is also used to delay the input signal to prevent distortion of input pulse width.

5.6 Minimum ON time

In order to ensure the proper operation of the 2-level turn-off function, the input ON time (T_{win}) must be greater than the T_{winmin} value:

R_{del} is the internal discharge resistor and C_{off} is the external timing capacitor.

Input signals smaller than T_a are ignored. Input signals larger than T_{winmin} are transmitted to the output stage after the T_a delay with minimum width distortion ($\Delta T_w = T_{wout} - T_{win}$).

For an input signal width T_{win} between T_a and T_{winmin} , the output width T_{wout} is reduced below T_{win} (pulse distortion) and the IGBT could be partially turned on. These input signals should be avoided during normal operation.

5.7 Output

The output stage is able to sink 2.3 A and source 1.5 A (typ) at 25 °C (1.2 A/0.75 A minimum over the full temperature range). Separate sink and source outputs allow independent gate charge and discharge control without an extra external diode.

5.8 Fault status output

Fault output is used to signal a fault event (desaturation, UVLO) to a controller. The fault pin is designed to drive an optocoupler.

5.9 Undervoltage protection

Undervoltage detection protects the application in the event of a low VH supply voltage (during startup or a fault situation). During undervoltage, the OUTH pin is open and the OUTL pin is driven low (active pull-down for VH>2 V, passive pull-down for VH<2 V). Fault output signals the undervoltage state and is reset only when undervoltage state disappears.

VH UVL Vccmin

OUT 2V

AM02721v1

Figure 3. Undervoltage protection

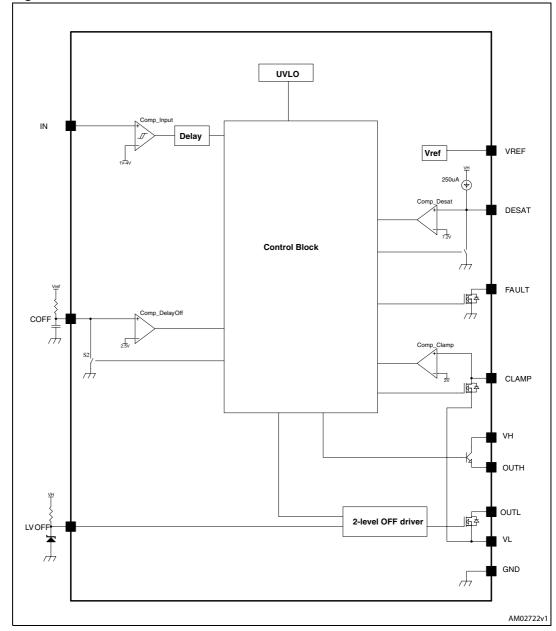


Figure 4. Detailed internal schematic

TD350E Timing diagrams

6 Timing diagrams

Figure 5. Turn-on and turn-off

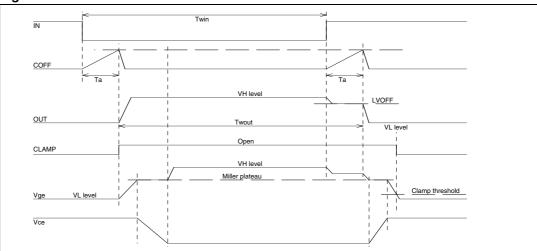


Figure 6. Minimum ON time

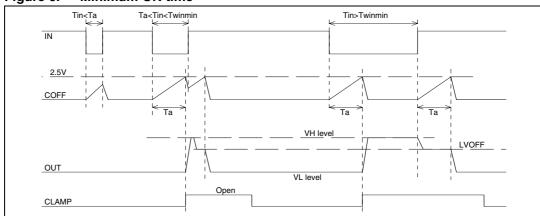
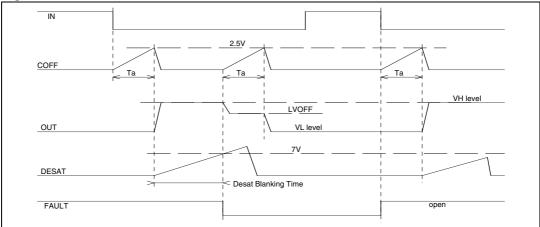


Figure 7. Desaturation fault



7 Typical performance curves

Figure 8. Supply current vs. temperature

5.0 4.0 3.0 E 2.0 1.0 0.0 -50 -25 0 25 50 75 100 125

Figure 9. Low level output voltage vs. temp.

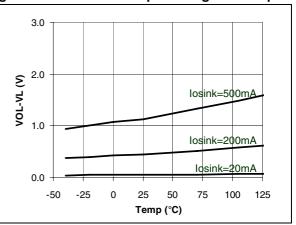


Figure 10. Desaturation threshold vs. temp.

Temp (°C)

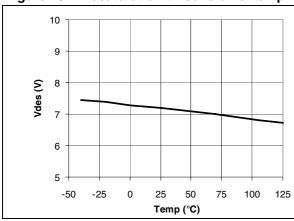


Figure 11. Voltage reference vs. temp.

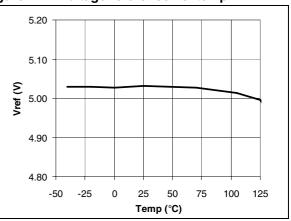
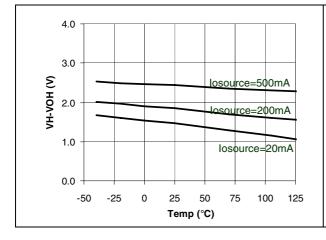
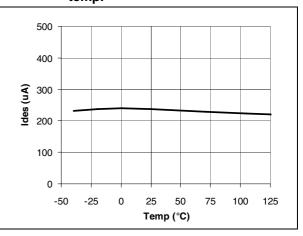


Figure 12. High level output voltage vs. temp. Figure 13. Desaturation source current vs. temp.





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8 Application diagrams

Figure 14. Single supply IGBT drive with active Miller clamp and 2-level turn-off

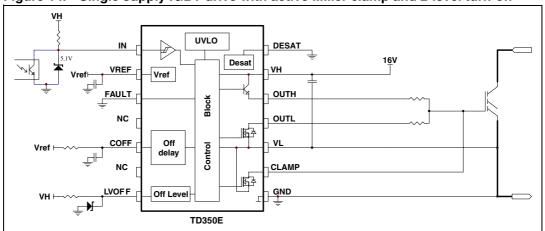


Figure 15. Large IGBT drive with negative gate drive and desaturation detection

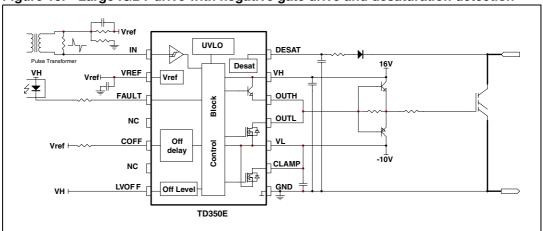
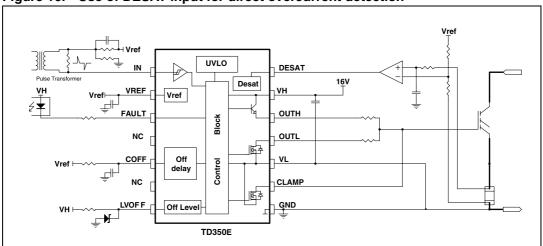


Figure 16. Use of DESAT input for direct overcurrent detection



9 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

Table 6. SO-14 mechanical data

Dim	mm.			inch			
Dim.	Min	Тур	Max	Min	Тур	Max	
Α			1.75			0.068	
a1	0.1		0.2	0.003		0.007	
a2			1.65			0.064	
b	0.35		0.46	0.013		0.018	
b1	0.19		0.25	0.007		0.010	
С		0.5			0.019		
c1		45° (typ.)					
D	8.55		8.75	0.336		0.344	
Е	5.8		6.2	0.228		0.244	
е		1.27			0.050		
e3		7.62			0.300		
F	3.8		4.0	0.149		0.157	
G	4.6		5.3	0.181		0.208	
L	0.5		1.27	0.019		0.050	
М			0.68			0.026	
S	8° (max.)						

D

A2 A

Ax45

B

A1

SEATING
PLANE
C

GAGE PLANE

O016019D

Figure 17. Package dimensions

Revision history TD350E

10 Revision history

Table 7. Document revision history

Date	Revision	Changes	
08-Mar-2011	1	First release.	
23-Sep-2011	2	Updated <i>Table 1</i>Minor text changes throughout the document	

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